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Preparation and structural-optical characterization of dip-coated nanostructured Co-doped ZnO dilute magnetic oxide thin films

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ZnO-based materials are one of the most studied systems. Their applicability spans over several research areas and industries, like optoelectronics, catalysis and spintronics. Here we demonstrate the feasibility to prepare Co-doped ZnO thin films ($\text{Zn}_{1-x}\text{Co}_x\text{O}$, with $x = 0; 0.01; 0.03$ and 0.05) deposited by the dip-coating technique, a very simple and a low-cost process. We focus the structural and the optical characterization in the context of dilute magnetic materials. Detailed analyses were carried out to investigate alternative sources of ferromagnetism, such as secondary phases and nanocrystals embedded in the nanostructured thin films. Conjugating different techniques, we confirmed the Zn replacement by Co ions in the ZnO wurtzite structure with no secondary phases up to $x = 0.05$. It was further observed that the major structural defects in the films are oxygen vacancies (V_O) and zinc interstices (Zn_i), and that the relative densities of these defects increase with the increase in Co concentration, which promotes the studied thin films to candidates to present room temperature ferromagnetism.

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1. Introduction

The development of novel spintronic materials and spin-based electronic devices is a hot topic of current research in materials science and condensed matter physics.^{1,2} Although a few spintronic devices based on ferromagnetic/non-magnetic heterostructures have been successfully realized,³⁻⁶ the addition of ferromagnetic properties to semiconductors has been revealed to be one of the most challenging task. Ferromagnetic semiconductors are interesting from the technological point of view, mainly due to the possibility of integration of spintronics in the conventional semiconductor technologies and to the introduction of new functionalities, like the control of magnetic properties through the manipulation of the density of free charge carriers and electric fields.⁷

In this context, too much research effort has been conducted on a family of materials called dilute magnetic semiconductors (DMSs). For these materials, transition metals (TM) are used as doping chemical elements into a specifically semiconductor host matrix. Mn-doped III-V semiconductors were found to be

ferromagnetic, nevertheless, the Curie temperature (T_C) for these materials is still far below room temperature, not exceeding 200 K.^{8,9} According to Dietl *et al.*,¹⁰ Mn-doped ZnO and GaN, wide band gap semiconductors, theoretically would present T_C above room temperature. However, the obtained results, especially for the TM-doped oxides such as ZnO, TiO_2 , CeO_2 , SnO_2 , *etc.*,¹¹⁻¹⁴ the dilute magnetic oxides (DMOs), regarding the origin of ferromagnetism, in retrospect, are now very controversial and inconclusive. The complete comprehension of the magnetic properties of these systems were hindered by several and different problems, among them we cite: the contamination by magnetic elements,¹⁵ measurement errors¹⁶ and the presence of not detected ferromagnetic segregated secondary phases.^{17,18} Today there is a consensus that the TM-doping is not a sufficient condition to achieve the room temperature ferromagnetism (RTFM),^{19,20} and that point defects in the structure of such materials play an important role to reach the desired magnetic properties.²¹⁻²⁵ Therefore, before to study the magnetic properties of these systems, it is preponderant to perform a carefully and detailed structural characterization in order to exclude the presence of any extrinsic magnetic component and to get some insight about the structural defects in the studied materials. From the theoretical point of view, the main models proposed to describe the origin and properties of ferromagnetism suppose that electrons, introduced by donor defects into the conduction band²⁶ or forming bound magnetic polarons (BMP),²⁷ mediate ferromagnetic couplings between TM ions in the oxide matrix. Another important model, attempting to explain the observed RTFM in

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undoped systems,²⁸ assigns the ferromagnetic response to spins of electrons residing on point or extended defects, the called d^0 ferromagnetism.²⁹

The aim of this present work is to prepare and present the structural and optical characterization of Co-doped ZnO thin films ($\text{Zn}_{1-x}\text{Co}_x\text{O}$) at concentrations of $x = 0; 0.01; 0.03$ and 0.05 , deposited by the dip-coating technique. In spite of the potential application of the ZnO-based materials in the development of spintronic devices, they are one of the really multi-functional materials, been also highly interesting as in solar cells,³⁰ gas sensing,³¹ transparent conductive oxides (TCOs),³² and also in catalysis,³³ just to cite few. Among the TM elements used to dope ZnO, Co deserves special attention, since it has one of the highest magnetic moments ($4.8 \mu_B$) and a positive magnetic exchange coupling constant in the metallic phase. Here, the global rout process of the thin films consists in preparing coating solutions from the Pechini method.³⁴ Precursor films, deposited by dip-coating are then heat treated to eliminated organic materials and to synthesize the inorganic phase. The polymeric precursor method presents many advantages, such as the possibility to work in aqueous solution and a high stoichiometric control. Moreover, it is a low temperature process and a cost-effective method involving inexpensive precursors and unsophisticated apparatus. We performed a detailed structural characterization by conjugating several different techniques, in order to exclude the presence of any contamination or segregated secondary phases that could lead to any extrinsic and undesired magnetic component. The optical characterization was employed to get fundamental insights concerning the nature and the relative density of defects in the prepared thin films.

2. Experimental

The $\text{Zn}_{1-x}\text{Co}_x\text{O}$ thin films were deposited on glass substrates by the dip-coating method with Co nominal concentrations of $x = 0$ (undoped ZnO); 0.01 ($\text{Zn}_{0.99}\text{Co}_{0.01}\text{O}$); 0.03 ($\text{Zn}_{0.97}\text{Co}_{0.03}\text{O}$) and 0.05 ($\text{Zn}_{0.95}\text{Co}_{0.05}\text{O}$). Flowchart in Fig. 1 illustrates the procedure employed in the preparation of the thin films. The dip-coating process consists of an equipment, provided with a stepper motor that, when moving the lever on which the substrate is fixed, allows to immerse and remove it from a coating resin prepared by the Pechini method.³⁴ Zinc nitrate hexahydrate, $\text{Zn}(\text{NO}_3)_2 \cdot 6\text{H}_2\text{O}$ (Sigma-Aldrich, >99%), and cobalt(II) nitrate hexahydrate, $\text{Co}(\text{NO}_3)_2 \cdot 6\text{H}_2\text{O}$ (Sigma-Aldrich, $\geq 98\%$), were the metal sources used in stoichiometric amounts in the synthesis of the precursor coating resin. In the first step, the nitrates were dissolved in an aqueous citric acid solution at 60°C under constant stirring for approximately 1 h. After achieve a completely homogeneous solution, ethylene glycol was added to promote an organic ester formation. Polymerization, promoted by heating the mixture up to 120°C , results in a homogeneous resin in which metal ions are uniformly distributed throughout the organic matrix. The citric acid/metal and citric acid/ethylene glycol mass ratios were $4 : 1$ and $60 : 40$, respectively. The viscosity was then adjusted to 15 cP by adding a controlled amount of water. Prior to coating, the

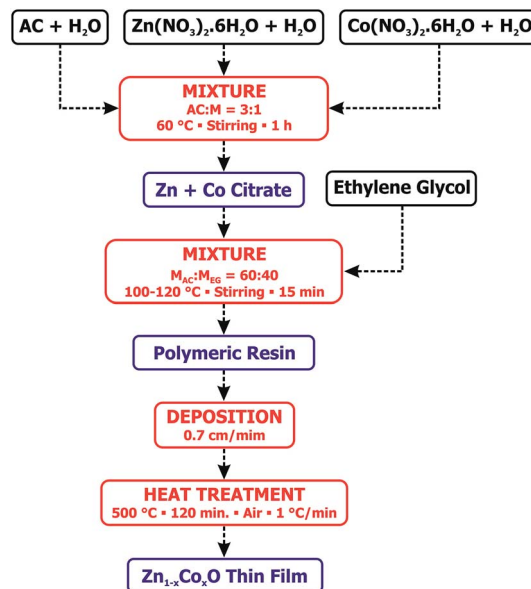


Fig. 1 Flowchart of the preparation of the $\text{Zn}_{1-x}\text{Co}_x\text{O}$ thin films using the polymeric precursor method.

substrates were cleaned in a sulfochromic solution followed by washing several times in de-ionized water and drying in hot air. The dip-coating was conducting by immersing the clean substrates in the polymeric resin followed by controlled withdrawal at the speed of 0.7 cm min^{-1} . After deposition, the substrates were dried on a hot plate ($\sim 150^\circ\text{C}$). Finally, the glass substrates with the deposited films were subjected to a heat treatment at $500^\circ\text{C}/2 \text{ h}$ in air, with heating rate of 1°C min^{-1} , in order to remove the organic materials and to promote the crystallization of the thin film. The average thicknesses of the films were measured by using a Talystep Taylor-Hobson profiler. The obtained value for all the thin films were $400 \pm 10 \text{ nm}$.

The structural characterization was investigated by powder X-ray diffraction (PXRD) using a Rigaku Ultima IV diffractometer, geometry θ - 2θ , $\text{Cu-K}\alpha$ ($\lambda = 1.5418 \text{ \AA}$) radiation and a $\text{LiF}(100)$ monochromator. The PXRD data were measured in a step-scan mode at room temperature, in a range of $2\theta = 10$ – 90° with a rate of $0.02^\circ/5 \text{ s}$. The structure morphology and the elemental composition were characterized by scanning electron microscopy (SEM) and energy dispersive X-ray spectrometry (EDS) by means of a FEI Inspect F50, equipped with an Oxford EDS detector, model X-MAX 80. The optical properties were evaluated *via* optical transmittance (UV-Vis) and photoluminescence (PL) techniques. The UV-Vis measurements were performed on a Carry-17 spectrometer operating in a region from 300 to 900 nm. The PL measurements were performed at a 5 K temperature with a Kimmon Koha He–Cd laser at 325 nm, as the source of excitation. Finally, the local structure of the Co dopants into the ZnO matrix and their oxidation state were determined by X-ray absorption techniques (X-ray absorption near-edge structure – XANES and extended X-ray absorption fine structure – EXAFS). The X-ray absorption measurements were performed at the Co K-edge in transmission mode using



a Si(111) channel-cut monochromator at the XAFS2 beamline from the Brazilian Synchrotron Light Laboratory (LNLS), Campinas, Brazil. The extraction, normalization and fitting of the EXAFS spectra were performed using the Multiplatform Applications for XAFS (MAX) software package and theoretical spectra were obtained using the FEFF9 code.^{35,36}

3. Results and discussions

Fig. 2 shows the diffractograms obtained for the prepared thin films. For all samples, the diffraction peaks correspond to those of the ZnO wurtzite structure (ICDD crystal chart no. 36-1451). The results show that, within the technique limits of detection, there are no secondary phases present in the thin films, indicating that the Co ions are incorporated into the ZnO matrix. The observed wide curve superimposed on the ZnO wurtzite diffraction peaks at lower angles (2θ from 15° to 40°) is associated to the diffraction of the amorphous material of the glass substrate.

The study of the thin film morphology and chemical composition was carried out using both scanning electron microscopy (SEM) and energy dispersive X-ray spectroscopy (EDS) techniques. Fig. 3 shows the data obtained for the undoped ZnO sample, a representative image of the thin film

surface (Fig. 3(a)) with the respective EDS spectrum (Fig. 3(b)) and the obtained histogram used for the statistical analyses of the grain diameter distribution (Fig. 3(c)). The obtained statistical data for the other samples are similar to those shown in Fig. 3 and are summarized in Table 1.

We observed that thin films have a nanometric granular structure (inset of Fig. 3(a)). Scans were performed on several areas of the thin films in order to search for potential segregated secondary phases and EDS analyses were carried out on the suspect grains. The presence of these phases was not detected at any point, strongly suggesting that Co ions in the studied thin films is in substitutional character to the Zn^{2+} ions into the ZnO wurtzite matrix. The EDS analyses also give the Co concentrations in semi-quantitative values. The measured average effective Co concentrations (x_E) listed in Table 1 are in good agreement with the nominal stoichiometry of the thin films. The statistical analyses were conducted by measuring the grain sizes in different images with the aid of Image Pro 4 software. The obtained histograms were then fit by a log-normal function, which gives the geometric main grain diameter (d) and the geometric standard deviation (σ_g) of the distributions. The obtained results are also listed in Table 1. We observe that the grain median diameters are of order of 50 nm and that the geometric standard deviation for all the thin films are lower than 1.25. Considering that a grain size distribution is said to be monodispersed if $\sigma_g \leq 1.25$,³⁷ we can state that the grain sizes of our thin films are quite homogeneous.

Now, we proceed to the optical characterization results. Fig. 4(a) shows the transmittance spectra for the thin films, in the range from 350 to 850 nm measured at room temperature. The observed spectra were very similar to those found in literature,³⁸ with the ZnO absorption edge in the range of 380 nm

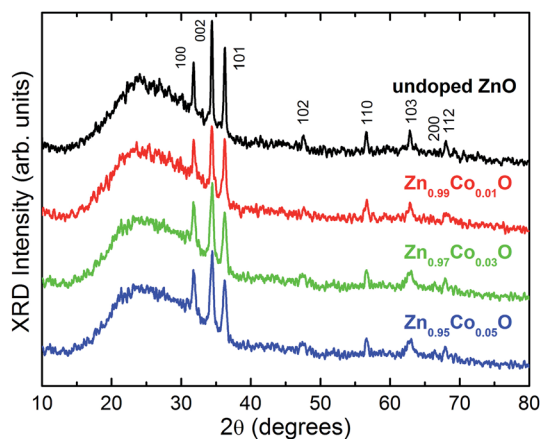


Fig. 2 Powder X-ray diffractograms (Cu-K α) obtained for the $\text{Zn}_{1-x}\text{Co}_x\text{O}$ thin films. The crystalline planes for each diffraction peak, given in the Miller indices (ICDD PDF no. 36-1451), are also shown.

Table 1 Particle size distribution analyses. Effective Co concentration (x_E), median diameter (d), geometric standard deviation (σ_g) and the total number of counted particles (N)

Sample	x_E	d (nm)	σ_g	N
Undoped ZnO	—	56(1)	1.25(2)	168
$\text{Zn}_{0.99}\text{Co}_{0.01}\text{O}$	0.010(1)	45.9(7)	1.21(2)	76
$\text{Zn}_{0.97}\text{Co}_{0.03}\text{O}$	0.030(1)	56.2(9)	1.18(1)	111
$\text{Zn}_{0.95}\text{Co}_{0.05}\text{O}$	0.048(1)	48(1)	1.17(1)	281

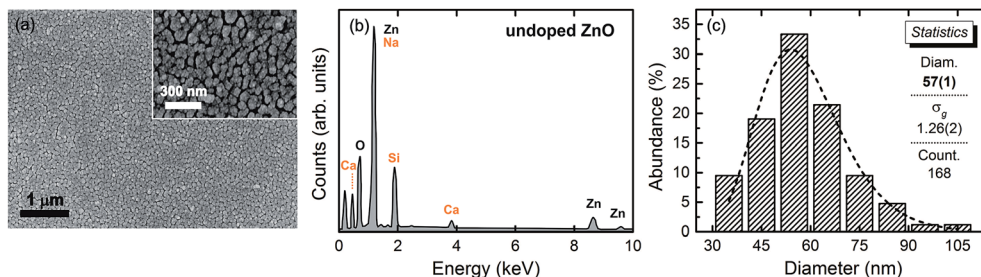


Fig. 3 (a) Representative micrograph obtained by SEM for the undoped ZnO thin film; (b) respective EDS spectrum of the visualized area in (a), the elements corresponding to the glass substrate are Ca, Na and Si. (c) Particle size distribution histogram for the undoped ZnO sample. The dashed line in (c) corresponds to a log-normal fit.



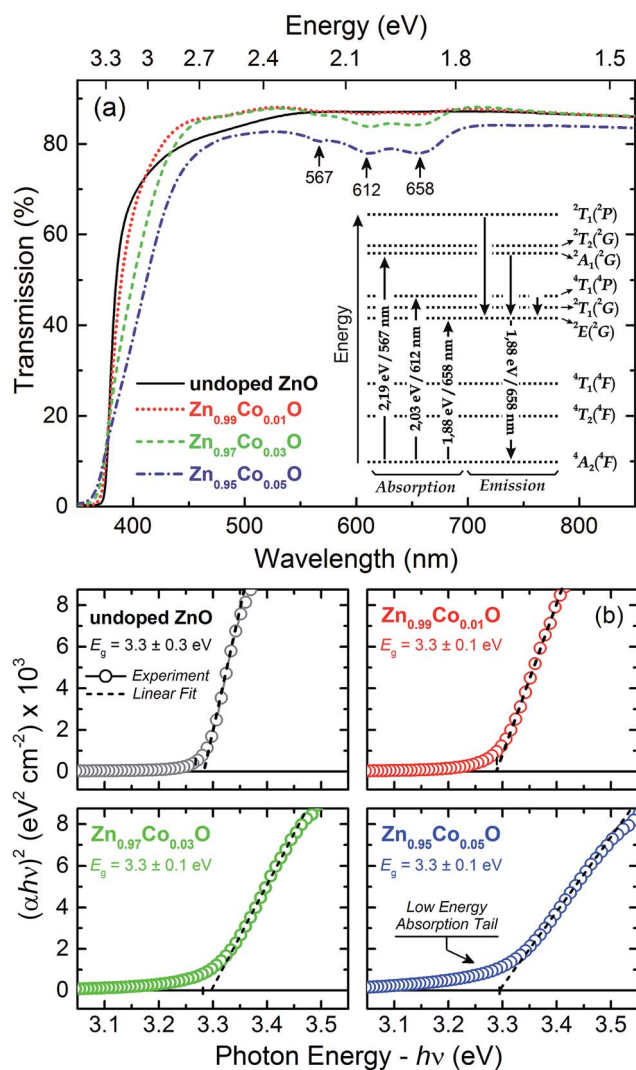


Fig. 4 (a) Transmission spectra (UV-Vis) in the range from 350 to 850 nm for the Zn_{1-x}Co_xO thin films. Inset in (a) is the energy diagram for Co²⁺ ions at a tetrahedral site (out off-scale). (b) $(\alpha h\nu)^2$ curves as a function of the energy of the incident photon near the band gap region of the thin films. The intercept of the line segments (dashed lines), obtained from the linear fitting of the absorption edges, with the energy axis gives the direct value of the energy band gap (E_g).

and absorption bands at 567, 612 and 658 nm associated with Co²⁺ ions at the 3d⁷ tetrahedral coordination, with the ⁴F state corresponding to the lowest energy state, as well as the ⁴P, ²G, ²P, ²H and ²D states corresponding to the excited states.³⁹ Once in a tetrahedral site, the ⁴F state splits into ⁴A₂(⁴F), ⁴T₂(⁴F) and ⁴T₁(⁴F) due to the crystalline field, here, ⁴A₂(⁴F) state became the fundamental one. Likewise, the ²G state splits into ²A₁(²G), ²E(²G), ²T₁(²G) and ²T₂(²G). However, the excited states ⁴P and ²P do not split, but are converted into the ⁴T₁(⁴P) and ²T₁(²P) states, respectively. The inset in Fig. 4(a) shows the energy diagram for Co²⁺ ion in a tetrahedral site. In this context, the absorptions observed at 567, 612 and 658 nm is attributed to the transitions ⁴A₂(⁴F) → ²A₁(²G), ⁴A₂(⁴F) → ⁴T₁(⁴P) and ⁴A₂(⁴F) → ²E(²G).⁴⁰ Therefore, the observation of these transitions for our doped thin films is an indication that the Co ions in ZnO matrix

have a +2 oxidation state and are located in a tetrahedral site. In the wurtzite structure of the ZnO matrix, the tetrahedral sites correspond to those of the Zn²⁺ ions, thus we can state that the Co in our films is in substitutional character to Zn in the ZnO wurtzite structure of the thin films.

The calculation of the effective optical band gap (E_g) of the thin films were performed by the Tauc method.⁴¹ Fig. 4(b) shows the $(\alpha h\nu)^2$ graphs as a function of the excitation energy, as well as the E_g values obtained by the linear fitting the edge of the $(\alpha h\nu)^2$ curves for the studied thin films. We observed that there is no significant variation of E_g as a function of Co doping, remaining with an average value of 3.30 eV. This result indicates that the doping does not significantly introduce structural distortions in the ZnO matrix. In the ZnO wurtzite structure, the Zn²⁺ ion in a tetrahedral coordination has a crystal radius of 0.74 Å; whereas, the Co²⁺ ion in the same structure, in a tetrahedral coordination, must have a crystalline radius of 0.72 Å, very little different from the Zn²⁺ crystal radius.⁴² Given the small difference between the crystal radii of these two elements, it is would be expected that the Co doping of the ZnO matrix would does not introduce significant distortions, considering that the Co²⁺ ions replaces the Zn²⁺ ions by taking over its position in the ZnO structure. In fact, this was what we observed, so that the obtained result also indicates the substitutional character of Co doping in our Zn_{1-x}Co_xO thin films.

Another important feature observed in the Tauc plots is the evident decrease of the slope of the edge and a formation of a low energy absorption tail as increasing the Co content in the thin films. In studies of amorphous solids, the slope of the Tauc plot has been used as a measure of the disorder effects in the band edge. The disorder effects become larger, than the slope becomes gentler. In fact, disorder generates defects, and these, in turn, remove states from the bands and generate band tails of localized states.^{43,44} The appearance of a low energy absorption tail with the Co-doping into the ZnO matrix has been reported previously by us and other authors,^{25,44} and was attributed to the formation of an impurity band near to the conduction band edge due to the overlapping of states introduced by the Co-doping.⁴⁵ These assumptions were further confirmed by the PL analyses.

Point defects directly affect the band structure of a material, playing a very important role in the optical, electrical and magnetic properties of TM-doped oxide systems. However, the study of point defects in materials is a very hard task. One of the most important defect characterization techniques, once taking into account theoretical calculations of electronic structure, is the PL measurements. In this sense, we carried out PL measurements in our thin films, in order to obtain information about the electronic structure, and to identify the major defects present in the films, as well as their relative densities. Fig. 5(a) shows the spectra obtained for the Zn_{1-x}Co_xO thin films. The spectra can be divided into three distinct emissions: (i) an emission at approximately 3.35 eV, addressed to transition between states close to the ZnO conduction and valence band edges; this band is denominated as near band edge emission (NBE); (ii) a large emission extending from approximately 3.25 eV to 1.6 eV, associated with structural defect transitions; and (iii) the Co²⁺ emission band at around 1.86 eV.



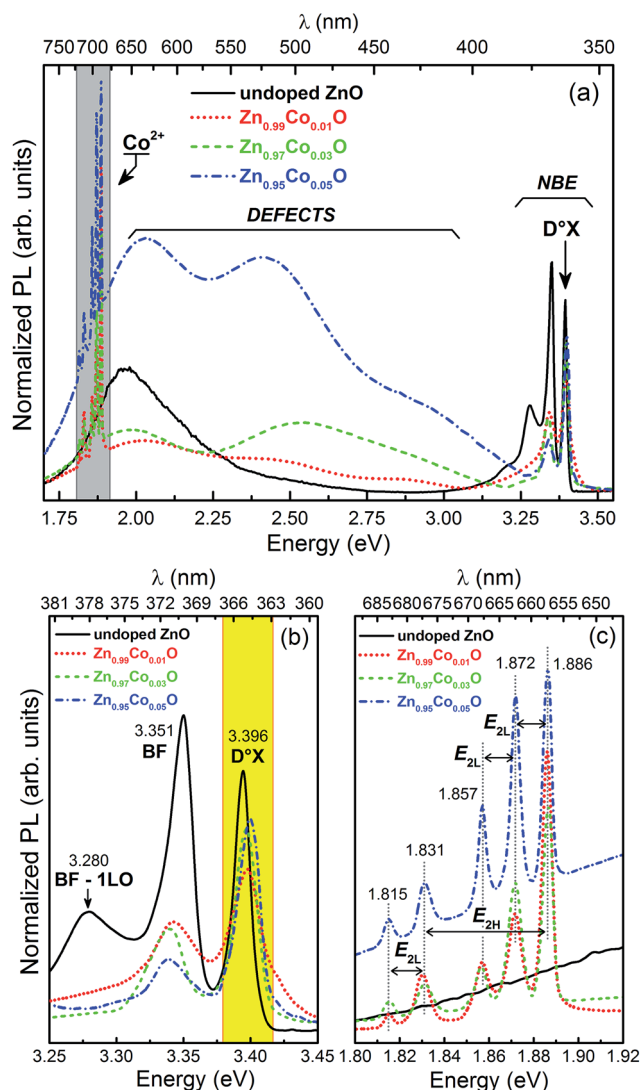


Fig. 5 (a) Photoluminescence spectra obtained at a 5 K for the $\text{Zn}_{1-x}\text{Co}_x\text{O}$ thin films. The spectra are normalized by the integrated area of the denominated D°X emission band in the NBE region. Details of spectra in the NBE region (b) and in the Co^{2+} emission region (c).

Fig. 5(b) shows the NBE emission in detail. We can observe three different emission bands in this region. The band at 3.40 eV is associated with excitons bound to neutral donors defect state (D°X). The band centered at 3.35 eV is associated with recombination of electrons bound to donor defects with free holes in the valence band (BF); finally, the emission at 3.28 eV is a longitudinal optical (LO) phonon replica of the BF emission (BF-1LO), corresponding to 70 meV below the BF energy.⁴⁶ Fig. 5(c) shows the Co^{2+} emission region. The emission band at 1.886 eV is associated with relaxations from excited states to ${}^2\text{E}({}^2\text{G})$ state, followed by a transition from ${}^2\text{E}({}^2\text{G})$ to the ${}^4\text{A}_2({}^4\text{F})$ ground state of Co^{2+} in the 3d^7 configuration in a tetrahedral crystalline field formed by the O^{2-} ions in its neighborhood (inset in Fig. 4(a)). The energy difference between the bands at 1.886 eV and 1.831 eV is 0.055 eV, which exactly corresponds to the energy of the vibrational mode $\text{E}_{2\text{H}}$ (0.054 eV/ 437 cm^{-1}), normally observed for both undoped and TM-doped

ZnO wurtzite structure.^{24,47,48} The difference in energy among the 1.886 eV, 1.872 eV and 1.857 eV bands, as well as the energy difference between the 1.831 eV and 1.815 eV bands, are 0.014 eV, 0.015 eV and 0.16 eV, respectively. These values, in turn, are in accordance with the energy for the vibrational mode $\text{E}_{2\text{L}}$ (0.013 eV/ 105 cm^{-1}).⁴⁹ The identification of these phonons in the PL spectra related to the Co^{2+} inner transitions is a clearly evidence that the Co ions in our thin films are, in fact, incorporated into the ZnO matrix.

Fig. 6 presents in more details the spectral region where it is observed the emission bands related to structural defects. The spectra were adjusted by Gaussians curves in order to identify and determine the relative contribution of each emission band. The observed spectra were composed of three emission bands centered on approximately 1.984 eV (620 nm – red), 2.449 eV (506 nm – green) and 2.895 eV (428 nm – blue); except for the undoped ZnO thin film, for which we observed an additional band at 2.182 eV (568 nm – green) but the band at 2.895 eV is not observed. As mentioned before, indexing the observed bands to specific defects is a difficult task, and is still a very controversial issue, leading to intense debate in the academic community. We have decided to follow both experimental and theoretical representative ref. 50–52. Here, the band around 1.984 eV is associated with oxygen vacancies (V_O), whereas, the band at approximately 2.182 eV is attributed to oxygen interstitial (O_i). The band at approximately 2.449 eV, in turn, is related to transitions between acceptor levels and shallow donors, the

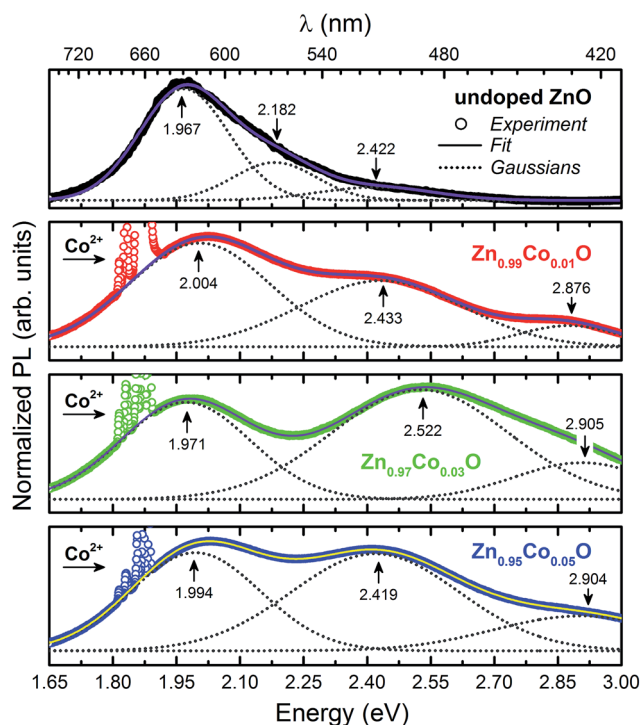


Fig. 6 Detail of the emission spectra of the $\text{Zn}_{1-x}\text{Co}_x\text{O}$ thin films in the region associated with structural defects. The symbols correspond to the experimental data, whereas, the dotted lines correspond to the Gaussian ones, used to adjust the emission spectrum for each thin film. The solid lines correspond to the obtained fitting.

most promising candidates are interstitials zinc (Zn_i) and zinc vacancies (V_{Zn}). Finally, the band at 2.895 eV can be associated directly with Zn_i . It is worthy to note that we would expect to observe an emission band also directly associated with the V_{Zn} defects around 3 eV and 3.1 eV, that is, close to the NBE region. Nevertheless, we did not explicitly observe this band (Fig. 5(a)), which means that if these defects existed in our thin films, at least they are in relative low concentrations.

The relative intensities of the emission bands can be directly correlated to the defect densities present in the thin films. Table 2 present the intensities (integrated areas) obtained after the Gaussian fit of the acquired spectra for the thin films. We observed that in a general way the defect bands intensities increases as the Co content increases, and that the structural defects mostly present in the $Zn_{1-x}Co_xO$ thin films are V_O and Zn_i . These data corroborate the observed behavior in the UV-Vis analyses where disorder related defects increases as a function of the Co concentration in the thin films. In particular, concerning the emission bands associated with defects at the Zn sites ($Zn_i \rightarrow V_{Zn}$ and Zn_i), as we did not observe an emission band directly associated with V_{Zn} , we interpreted the increase of the intensities of these emissions with the Co-doping due to the increase in the Zn_i concentration. This interpretation lead us to infer that the dynamics of the Co incorporation into the ZnO matrix starts by filling the empty Zn sites (decreasing of the V_{Zn}), and then, from a determinate point, pushing the Zn ions to interstitials sites (increasing of the Zn_i). Whereas, the bands associated to the defects at the oxygen site (V_O e O_i), which is very evident in the undoped ZnO thin film spectrum, did not present a correlation with the Co-doping. The V_O emission band initially decreased with the doping ($Zn_{0.99}Co_{0.01}O$), but then it started increasing ($Zn_{0.97}Co_{0.03}O$ and $Zn_{0.95}Co_{0.05}O$), while the O_i emission band completely disappeared in all the spectra for the Co-doped thin film. The increase in the intensity of the V_O emission band for the Co-doped thin films, as will be presented below, corroborates the results obtained in XANES analyses, corresponding to the variations in white-line absorption peak intensity.

Fig. 7(a) shows the XANES spectra obtained for the $Zn_{1-x}Co_xO$ thin films at the Co K-edge and for the reference Co oxides: CoO (oxidation state +2), Co_2O_3 (+3) and metallic Co (0). We observed that the absorption edge for the thin films corresponds to the absorption edge of the reference oxide CoO, in a way that we can concluded that the Co predominantly takes on the oxidation state +2 in our thin films. Once that the Zn has +2 oxidation state in the ZnO wurtzite matrix, it was expected that

Co would too occupy the same state, if it had been in a substitutional character to Zn. Therefore, this result is another indication that Co^{2+} ions in our samples occupy the sites of the Zn^{2+} ions in the ZnO wurtzite structure. Furthermore, we observed that the white-line (maximum after absorption edge) decreases and shifts to lower energies with the increase in Co concentration, inset in Fig. 7(a). This behavior is directly associated with an increase in the empty states left by open bonds due to oxygen vacancies (V_O).¹¹ This result corroborates the data obtained from PL presented above, concerning the relative intensities of the emission bands associated with the V_O . The XANES is also very sensitive to the local geometry around the absorber atom and therefore, can be used as a signature to identify the Co site location in the analyzed structure.^{53,54} In Fig. 7(a), we observed the presence of peaks in the pre-edge region in the absorption spectra of the $Zn_{1-x}Co_xO$ thin films. The pre-edge peak specifically originates from $s \rightarrow d$ transitions. In principle, the dipole selection rules do not allow this excitation. However, the observation of a pre-edge peak is associated with the existence of hybridization between the p and d states, which, in turn, is only possible if the site, where Co is located, does not have an inversion center of symmetry, as in a tetrahedral configuration. Therefore, the presence of the pre-edge peak in the obtained spectra lead us to state once more that in our thin films the Co^{2+} ions are located in tetrahedral sites, what would be expected considering that the Co^{2+} ions are replacing the Zn^{2+} ones in the ZnO wurtzite structure.

The shape of the absorption edge depends on the unfilled local density of states and the coordination symmetry of the absorbing element. Fig. 7(b) shows the extended XANES spectra obtained for the thin films at the Zn and Co K-edges. A very large correlation among the oscillations is observed, unlike other magnetic semiconductors where the transition metal atoms are in interstitial sites in the host matrix.^{55,56} Thus our results for the XANES spectra strongly indicate a substitutional incorporation of Co into the ZnO matrix.⁵⁴

The short-range structural data provided by extended X-ray absorption fine structure (EXAFS) spectroscopy offer element specific insight, furnishing quantitative information about the numbers, positions, and identities of atoms surrounding the absorbing element, as well as structural disorder within the coordination spheres. The fitted k^3 -weighted Fourier transforms (FT) of the $Zn_{1-x}Co_xO$ thin films are shown in Fig. 8(a), and the fitting and experimental EXAFS spectra of the back-transformations are shown in Fig. 8(b). The EXAFS data were obtained at Co K-edge for the studied thin films. The extraction and fitting of EXAFS spectra were performed using Multi-Platform Applications for X-ray absorption (MAX). *Ab initio* FEFF9 code was used to calculate the theoretical spectra. To obtain quantitative structural data concerning the first coordination shells, the neighborhood of Co atoms was modeled through the two main peaks corresponding to the two successive O spheres (between 1.5 and 3.0 Å) from FT-EXAFS. In all fits, we considered single and multi-scattering paths corresponding to the four successive atomic shells around Co substitutionally placed at Zn sites of the ZnO structure according to the hexagonal wurtzite with $P6_3mc$ space group. It is observed in Fig. 8(a)

Table 2 Integrated areas of the defect related emission bands obtained from Gaussian fit of the spectra of the $Zn_{1-x}Co_xO$ thin films

Sample	V_O , 1.984 eV	O_i , 2.182 eV	$Zn_i \rightarrow V_{Zn}$, 2.449 eV	Zn_i , 2.895 eV
Undoped ZnO	11.3(1)	3.6(1)	1.73(3)	—
$Zn_{0.99}Co_{0.01}O$	7.28(2)	—	5.40(2)	1.06(1)
$Zn_{0.97}Co_{0.03}O$	8.35(1)	—	12.86(5)	3.26(5)
$Zn_{0.95}Co_{0.05}O$	32.0(1)	—	40.7(2)	15.1(2)



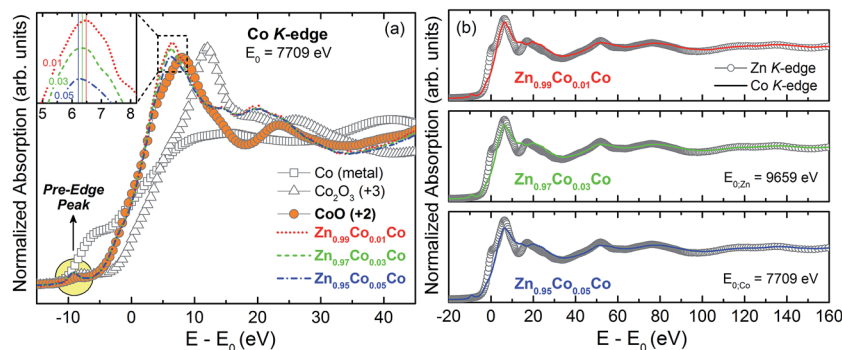


Fig. 7 (a) Co K-edge XANES spectra for the $\text{Zn}_{1-x}\text{Co}_x\text{O}$ thin films. Metallic Co, CoO (oxidation state +2) and Co_2O_3 (+3) spectra are also shown for comparison. The inset highlights the variation of the intensity of the white-line as a function of Co concentration. (b) Comparison of the Co and Zn K-edge extended XANES spectra.

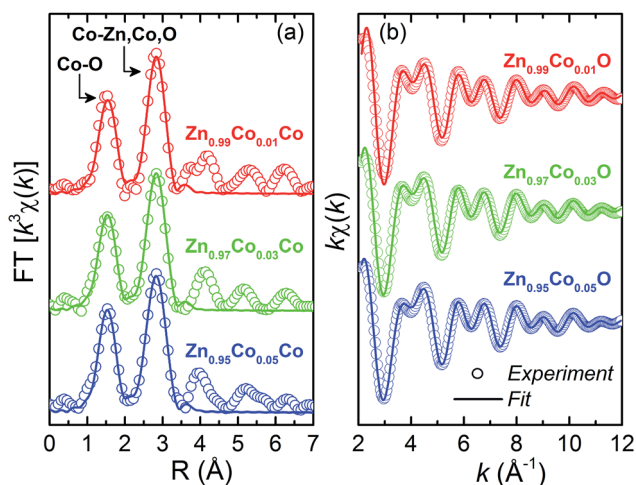


Fig. 8 (a) Fitted k^3 -weighted Fourier transforms (FT) of the $\text{Zn}_{1-x}\text{Co}_x\text{O}$ thin films and (b) fitted and experimental EXAFS spectra of the back-transformation. Open symbols are experimental data, and solid lines represent fittings using the parameters listed in Table 3. The spectra are offset for clarity.

Table 3 Co K-edge EXAFS simulation results. Interatomic distances (R), the average coordination number (N), Debye–Waller value (σ^2) and quality factor (QF)

Sample	Shell	R (Å)	N	σ^2 (Å ²)	QF
$\text{Zn}_{0.99}\text{Co}_{0.01}\text{O}$	Co–O	1.98(1)	4(1)	0.008(2)	3.51
	Co–Zn	3.19(2)	4(2)	0.008(1)	
	Co–Zn	3.24(1)	4(2)	0.008(1)	
	Co–O	3.75(1)	11(2)	0.006(2)	
$\text{Zn}_{0.97}\text{Co}_{0.03}\text{O}$	Co–O	1.98(1)	4.6(6)	0.006(2)	1.16
	Co–Zn	3.19(1)	6(1)	0.009(1)	
	Co–Zn	3.24(1)	6(1)	0.009(1)	
	Co–O	3.76(1)	9(2)	0.006(2)	
$\text{Zn}_{0.95}\text{Co}_{0.05}\text{O}$	Co–O	1.97(1)	4.2(6)	0.004(2)	1.11
	Co–Zn	3.18(8)	6(1)	0.010(1)	
	Co–Zn	3.25(2)	7(1)	0.010(1)	
	Co–O	3.71(1)	7(2)	0.004(2)	

and (b) a good correlation between the experimental data and the obtained theoretical simulation, corroborating the previous results in favor of the Co incorporation into the ZnO matrix in a substitutional character to Zn. The results obtained in the simulations, such as the values of the interatomic distances (R), the coordination number (N), the Debye–Waller values (σ^2) and the quality factor (QF) are presented in Table 3.

Analyzing the coordination number (N), we observed a reduction in the number of O neighbors, indicating an increase in the oxygen vacancies in the doping process, corroborating the XANES and the PL analyses concerning the presence and the increase of the V_{O} by increasing the Co content in the thin films. Likewise, there is an increase in the number of Zn neighbors, as we increase the Co-doping. This means that there is a relationship between the V_{Zn} reduction and the addition of Co to the ZnO matrix. Also corroborating the PL analyses related to the low concentration of V_{Zn} defects in the $\text{Zn}_{1-x}\text{Co}_x\text{O}$ thin films.

In the context of the magnetic properties of the dilute magnetic oxides (DMOs) the most accepted theoretical model is the spin-split impurity band model, also called bound magnetic polaron (BMP) theory.²⁷ The BMP theory states that the hybridization between the magnetic dopant and the defect levels leads to a delocalization of the carriers at the Fermi level over the magnetic dopants. In especial for the Co-doped ZnO, the Co^{2+} ions can hybridize effectively with shallow-donor impurity bands in ZnO because the states related to the complex Co^+ ($\text{Co}^{2+} + e_{\text{donor}}^-$) are also of shallow-donor character.⁴⁵ However, the nature of the specific donor point defect necessary to form the BMP is a matter of debate. On the literature one can find several experimental reports arguing, under the scope of the BMP theory, that oxygen vacancies (V_{O})^{44,57} are the responsible one of the often observed RTFM, besides, zinc interstitials (Zn_i) has been cited very often.^{22,58–60} However, the V_{O} state in the wurtzite ZnO is deep-donor state,^{51,61} and, although deeper-donors states can hybridize to magnetic dopants, their smaller Bohr radii would require relatively higher dopant and defect concentrations to achieve a necessary spatial overlapping, and at such short-range antiferromagnetic superexchange interactions would be observed, instead of the desired ferromagnetic coupling.⁴⁸ Therefore, the most promising



shallow-donor defect in the ZnO structure is the zinc interstitials (Zn_i).^{51,61} As we have directly addressed in the previous analyses, due the presence of both defects, V_O and Zn_i , in our thin films, in spite of the controversy and in the scope of the BMP theory, we can state that the studied samples would be candidates to present an intrinsic RTFM.

4. Conclusions

In summary, we shown that the polymeric precursor method is, besides its low-cost, a high-effective route of synthesis of nanostructured Co-doped ZnO ($\text{Zn}_{1-x}\text{Co}_x\text{O}$) thin films up to $x = 0.05$. From the structural point of view, the synthesis of nanostructured dilute magnetic oxides was successful. We performed a broad structural and optical characterization. The results confirm that Co^{2+} ions substitute for Zn^{2+} ions in the wurtzite ZnO matrix. There is no indication of Co-rich nanoclusters or segregated secondary phases in the samples. It was further observed that the major structural defects in the films are V_O and Zn_i , and that the relative densities of these defects increase with the increase of the Co concentration in the thin films. These results promote the studied thin films to candidates to present the desired ferromagnetic order at room temperature.

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